NSN 6625-00-411-9641

Semiconductor Device Test Set - Page 1 of 1



View Online at https://aerobasegroup.com/nsn/6625-00-411-9641

| Inclosure Feature: |
|-------------------------------|
| Single item w/housing |
| Test Type For Which Designed: |
| Transistor tester |
| Phase: |
| Single |
| Shelf Life: |
| N/a |
| Unit Of Measure: |
| |
| Demilitarization: |
| No |

Fiig: T228-a